

Application/Control No.	Applicant(s)/Patent under Reexamination AMAMIYA, YASUSHI	
An T. Luu	2816	

SEARCHED				
Class	Subclass	Date	Examiner	
		·		
-				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
See Alla	chment	1/6/2008	ATL		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST - Updated Search	1-16-08	ATL		
·				